

<b>Notice of References Cited</b>	Application/Control No. 10/721,379	Applicant(s)/Patent Under Reexamination JEON, KWANG-HOON	
	Examiner Kimnhung Nguyen	Art Unit 2629	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,747,620	06-2004	Jun, Il Jin	345/87
*	B	US-2003/0117484	06-2003	Vazan, Shahriar	347/236
*	C	US-2003/0035065	02-2003	Kim, Hak-Jae	348/558
*	D	US-6,788,309	09-2004	Swan et al.	345/629
*	E	US-7,098,903	08-2006	Park et al.	345/211
*	F	US-2002/0075412	06-2002	Tang et al.	348/607
*	G	US-6,873,308	03-2005	Sagano et al.	345/75.2
*	H	US-6,853,387	02-2005	Evanicky et al.	345/690
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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